

International **IR** Rectifier

IRLML6402PbF

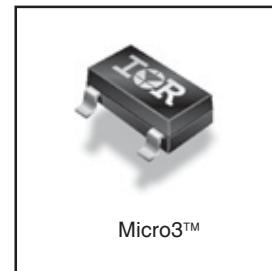
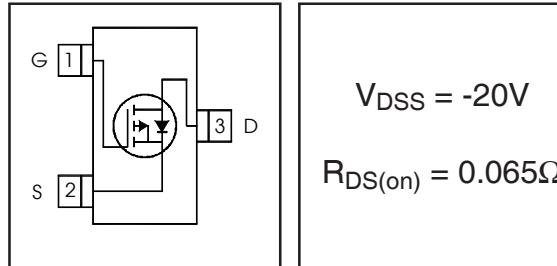
- Ultra Low On-Resistance
- P-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)
- Available in Tape and Reel
- Fast Switching
- Lead-Free
- RoHS Compliant, Halogen-Free

Description

These P-Channel MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in battery and load management.

A thermally enhanced large pad leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3™, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards. The thermal resistance and power dissipation are the best available.

HEXFET® Power MOSFET



Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRLML6402TRPbF	Micro3™ (SOT-23)	Tape and Reel	3000	IRLML6402TRPbF

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain- Source Voltage	-20	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -4.5V$	-3.7	
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ -4.5V$	-2.2	A
I_{DM}	Pulsed Drain Current ①	-22	
$P_D @ T_A = 25^\circ C$	Power Dissipation	1.3	
$P_D @ T_A = 70^\circ C$	Power Dissipation	0.8	W
	Linear Derating Factor	0.01	W/ $^\circ C$
E_{AS}	Single Pulse Avalanche Energy ④	11	mJ
V_{GS}	Gate-to-Source Voltage	± 12	V
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	$^\circ C$

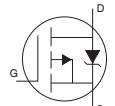
Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ③	75	100	$^\circ C/W$

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-20	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.009	—	$\text{V}/^\circ\text{C}$	Reference to 25°C , $I_D = -1\text{mA}$ ②
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	0.050	0.065	Ω	$V_{\text{GS}} = -4.5\text{V}$, $I_D = -3.7\text{A}$ ②
		—	0.080	0.135		$V_{\text{GS}} = -2.5\text{V}$, $I_D = -3.1\text{A}$ ②
		—	—	—		
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-0.40	-0.55	-1.2	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = -250\mu\text{A}$
g_{fs}	Forward Transconductance	6.0	—	—	S	$V_{\text{DS}} = -10\text{V}$, $I_D = -3.7\text{A}$ ②
I_{DSS}	Drain-to-Source Leakage Current	—	—	-1.0	μA	$V_{\text{DS}} = -20\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	-25		$V_{\text{DS}} = -20\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 70^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{\text{GS}} = -12\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{\text{GS}} = 12\text{V}$
Q_g	Total Gate Charge	—	8.0	12	nC	$I_D = -3.7\text{A}$
Q_{gs}	Gate-to-Source Charge	—	1.2	1.8		$V_{\text{DS}} = -10\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	2.8	4.2		$V_{\text{GS}} = -5.0\text{V}$ ②
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	350	—	ns	$V_{\text{DD}} = -10\text{V}$
t_r	Rise Time	—	48	—		$I_D = -3.7\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	588	—		$R_G = 89\Omega$
t_f	Fall Time	—	381	—		$R_D = 2.7\Omega$
C_{iss}	Input Capacitance	—	633	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	145	—		$V_{\text{DS}} = -10\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	110	—		$f = 1.0\text{MHz}$

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-1.3	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-22		
V_{SD}	Diode Forward Voltage	—	—	-1.2	V	$T_J = 25^\circ\text{C}$, $I_S = -1.0\text{A}$, $V_{\text{GS}} = 0\text{V}$ ②
t_{rr}	Reverse Recovery Time	—	29	43	ns	$T_J = 25^\circ\text{C}$, $I_F = -1.0\text{A}$
Q_{rr}	Reverse Recovery Charge	—	11	17	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ②

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ③ Surface mounted on 1" square single layer 1oz. copper FR4 board, steady state.
- ④ Starting $T_J = 25^\circ\text{C}$, $L = 1.65\text{mH}$, $R_G = 25\Omega$, $I_{AS} = -3.7\text{A}$.

** For recommended footprint and soldering techniques refer to application note #AN-994.

IR

IRLML6402PbF

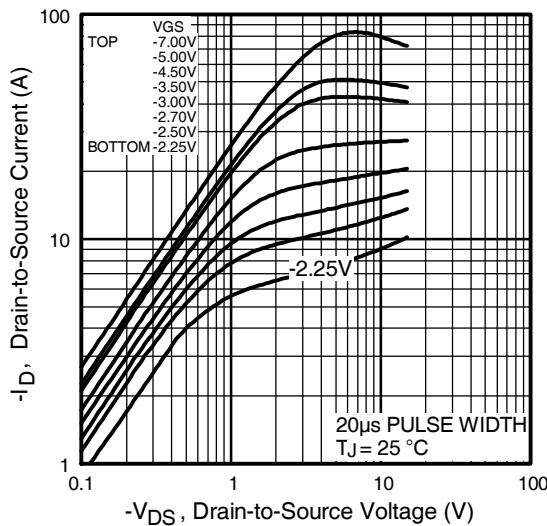


Fig 1. Typical Output Characteristics

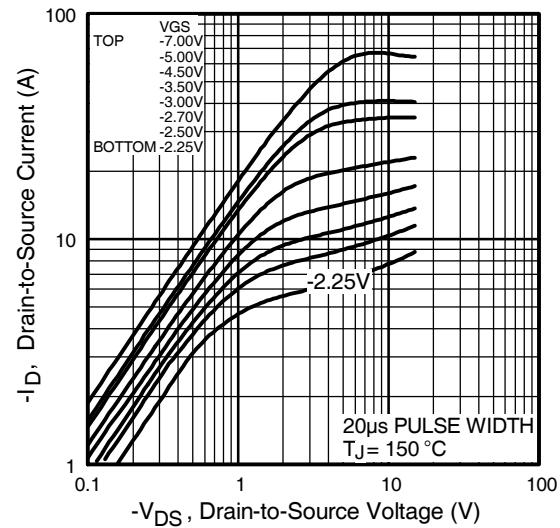


Fig 2. Typical Output Characteristics

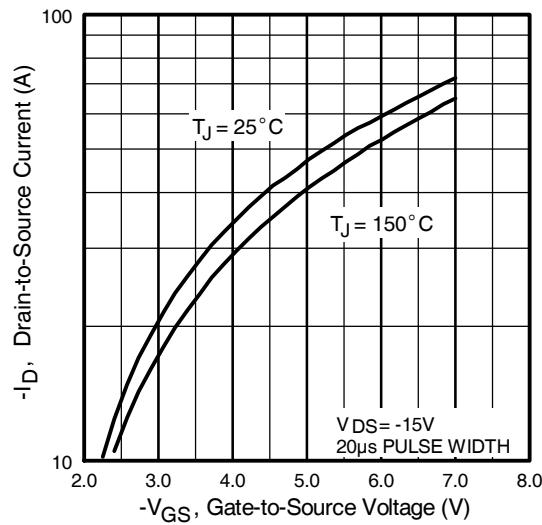


Fig 3. Typical Transfer Characteristics

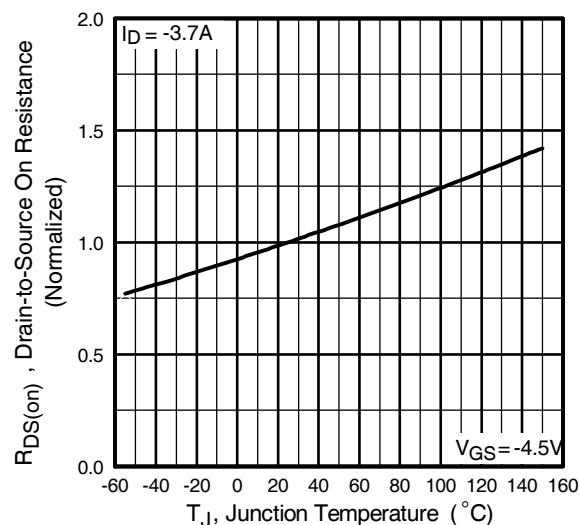


Fig 4. Normalized On-Resistance
Vs. Temperature

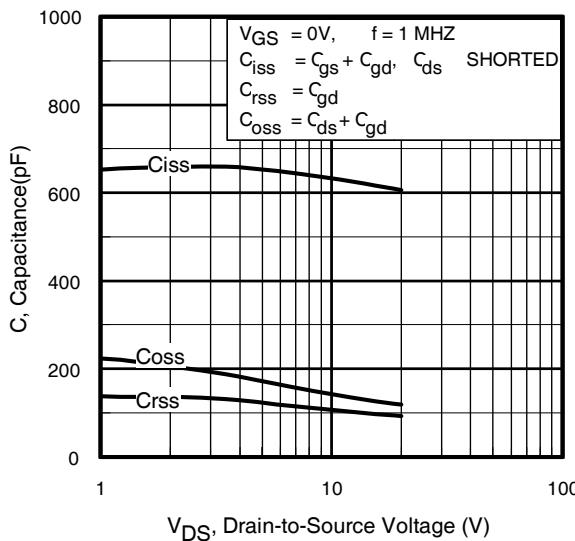


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

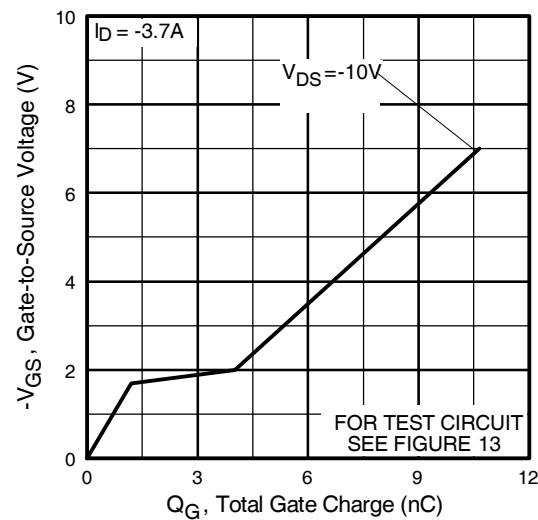


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

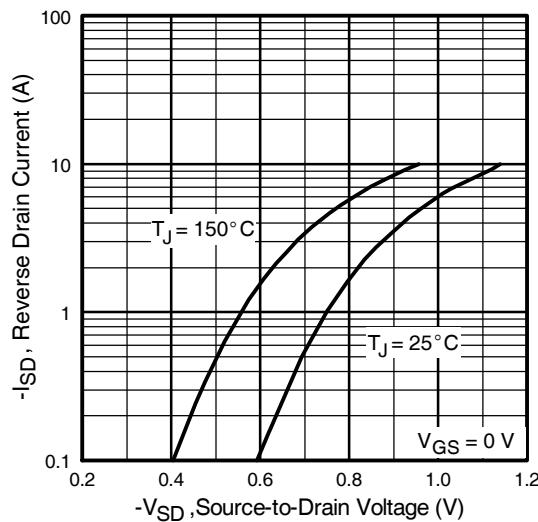


Fig 7. Typical Source-Drain Diode
Forward Voltage

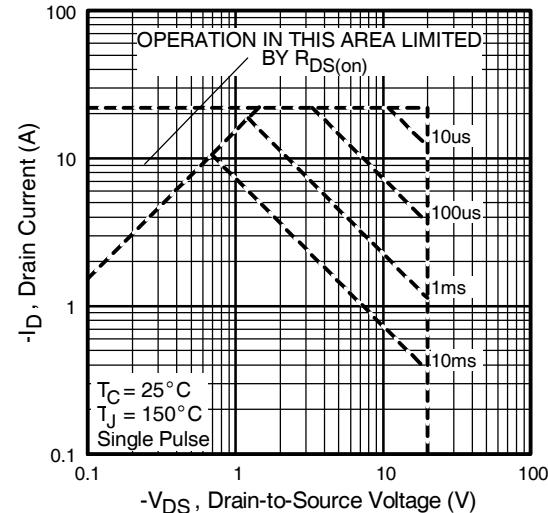


Fig 8. Maximum Safe Operating Area



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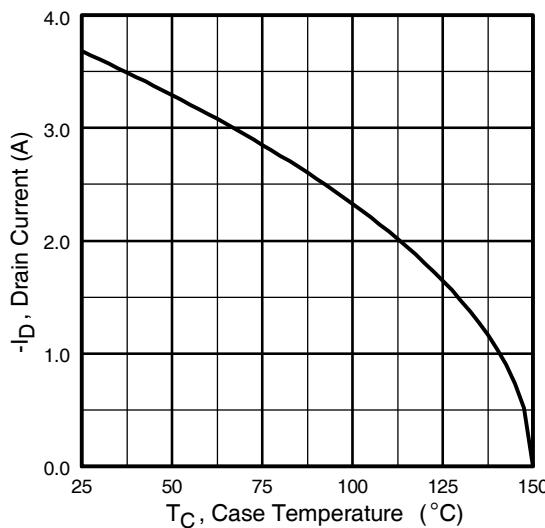


Fig 9. Maximum Drain Current Vs.
Case Temperature

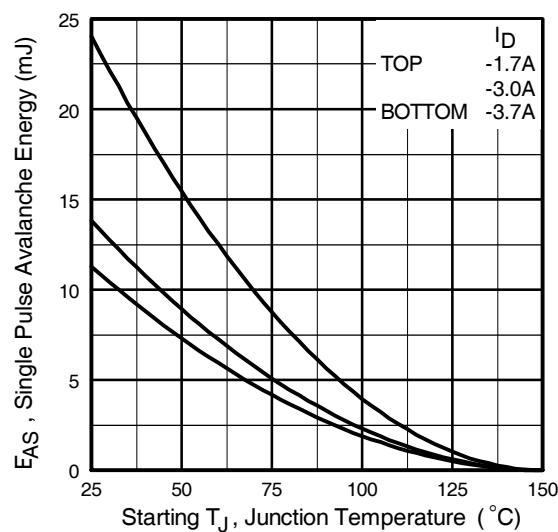


Fig 10. Maximum Avalanche Energy
Vs. Drain Current

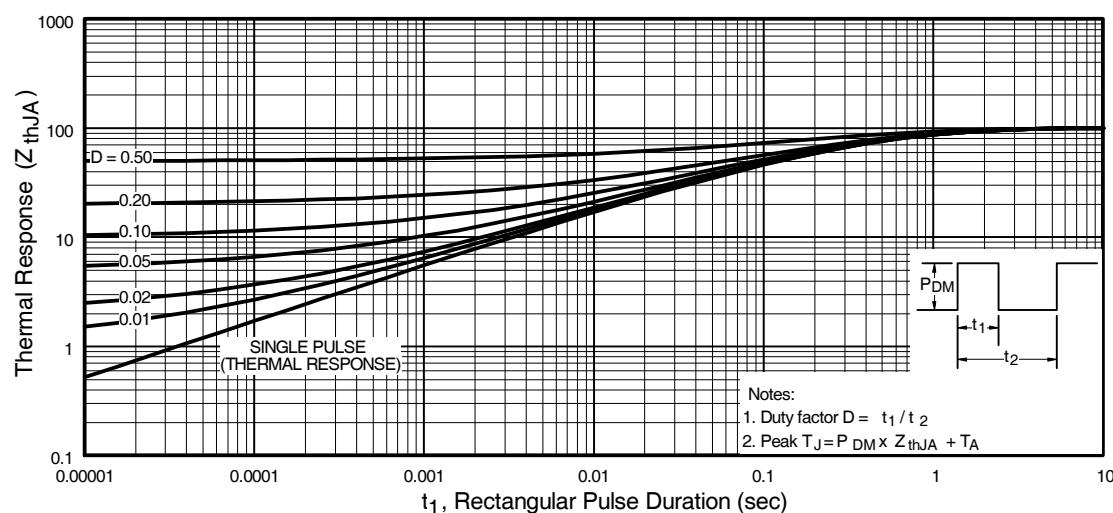


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

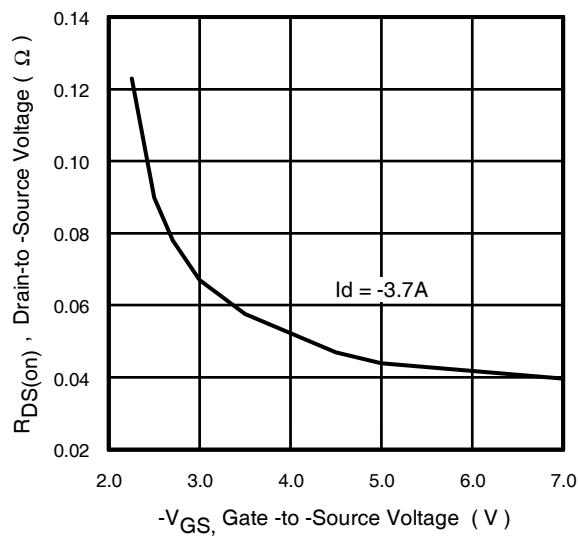


Fig 12. Typical On-Resistance Vs.
Gate Voltage

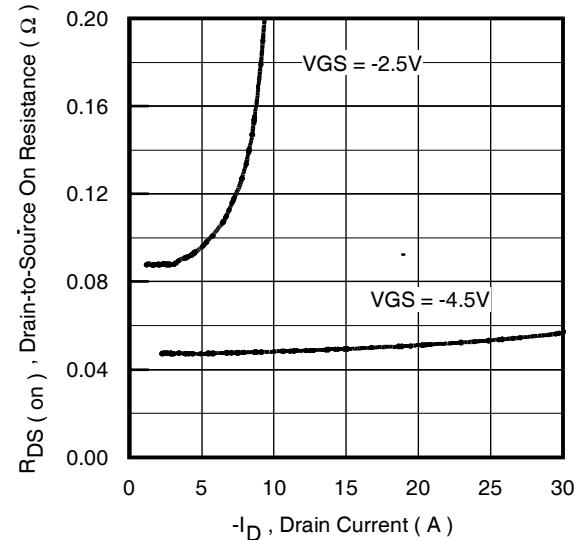


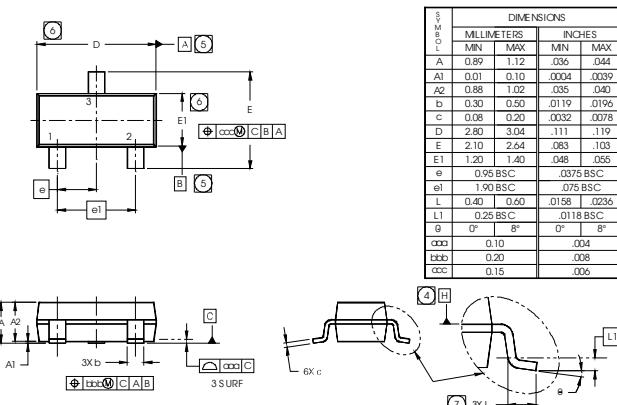
Fig 13. Typical On-Resistance Vs.
Drain Current



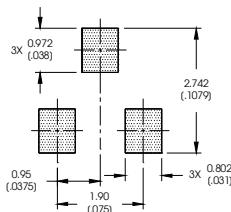
IRLML6402PbF

Micro3 (SOT-23) (Lead-Free) Package Outline

Dimensions are shown in millimeters (inches)



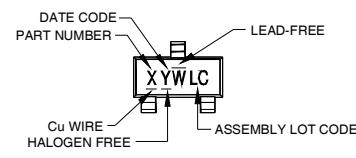
RECOMMENDED FOOTPRINT



NOTES
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS AND INCHES.
 3. CONTROLLING DIMENSION: MILLIMETER.
 (1) DATUM PLANE H IS LOCATED AT THE MOLD PARTING LINE.
 (2) DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.
 (3) DIMENSIONS D AND E1 ARE MEASURED AT DATUM PLANE H.
 (4) DIMENSION L IS THE LEAD LENGTH FOR SOLDERING TO A SUBSTRATE.
 6. OUTLINE CONFORMS TO JEDEC OUTLINE TO-236AB.

Micro3 (SOT-23 / TO-236AB) Part Marking Information

Notes: This part marking information applies to devices produced after 02/26/2001



W = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR

YEAR	Y	WORK WEEK	W
2011	2001	1	01 A
2012	2002	2	02 B
2013	2003	3	03 C
2014	2004	4	04 D
2015	2005	5	
2016	2006	6	
2017	2007	7	
2018	2008	8	
2019	2009	9	
2020	2010	0	24 X
			25 Y
			26 Z

X = PART NUMBER CODE REFERENCE:

A = IRLML2402	S = IRLML6244
B = IRLML2803	T = IRLML6246
C = IRLML6302	U = IRLML6344
D = IRLML5103	V = IRLML6346
E = IRLML6402	W = IRLML8244
F = IRLML6401	X = IRLML2244
G = IRLML2502	Y = IRLML2246
H = IRLML5203	Z = IRLML9244
I = IRLML0030	
J = IRLML2030	
K = IRLML0100	
L = IRLML0060	
M = IRLML0040	
N = IRLML2060	
P = IRLML9301	
R = IRLML9303	

W = (27-52) IF PRECEDED BY A LETTER

YEAR	Y	WORK WEEK	W
2011	2001	A	27 A
2012	2002	B	28 B
2013	2003	C	29 C
2014	2004	D	30 D
2015	2005	E	
2016	2006	F	
2017	2007	G	
2018	2008	H	
2019	2009	J	
2020	2010	K	50 X
			51 Y
			52 Z

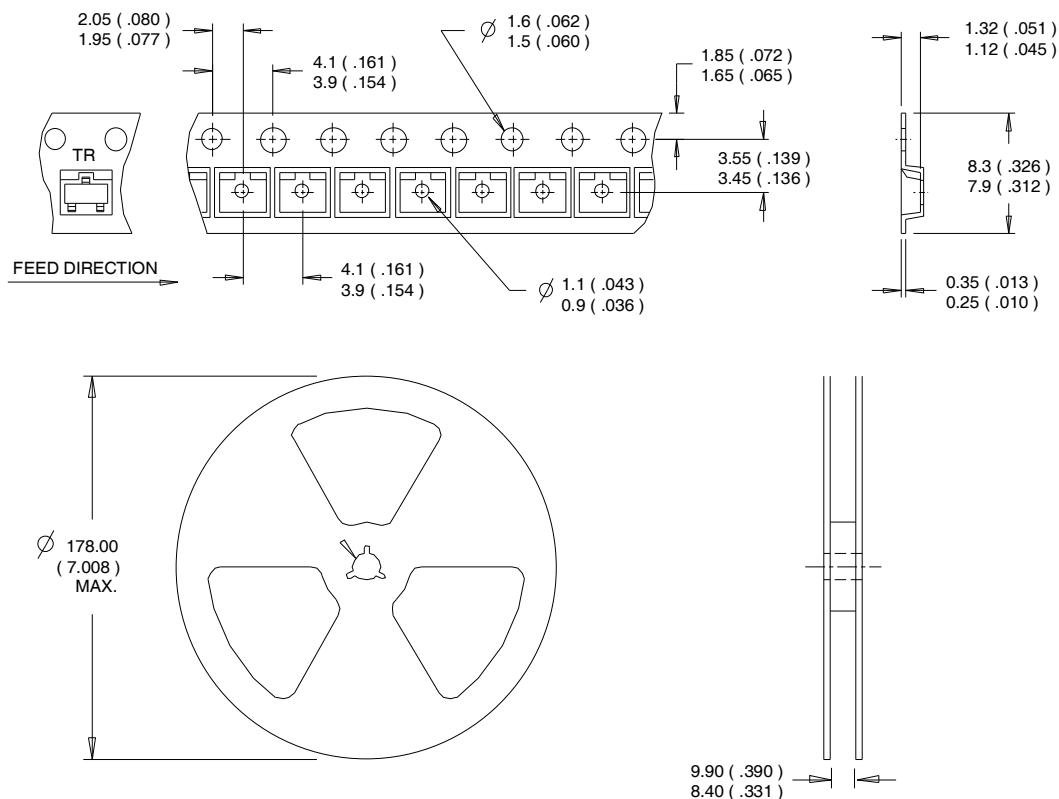
DATE CODE EXAMPLE:

YWW = 432 = DF
YWW = 503 = 5C

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package>

Micro3™(SOT-23/TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package>



IRLML6402PbF

Qualification information[†]

Qualification level	Consumer (per JEDEC JESD47F ^{††} guidelines)	
Moisture Sensitivity Level	Micro3™ (SOT-23)	MSL1 (per JEDEC J-STD-020D ^{††})
RoHS compliant	Yes	

[†] Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability>

^{††} Applicable version of JEDEC standard at the time of product release

Revision History

Date	Comment
4/28/2014	<ul style="list-style-type: none">• Updated data sheet with new IR corporate template.• Updated package outline & part marking on page 7.• Added Qualification table -Qual level "Consumer" on page 9.• Added bullet point in the Benefits "RoHS Compliant, Halogen -Free" on page 1.

International
IR Rectifier

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To contact International Rectifier, please visit <http://www.irf.com/whoto-call/>

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